

Search Notes

Application/Control No.

10/782,960

Examiner

Hien X. Vo

Applicant(s)/Patent under
Reexamination

SEKI, KEMPEI

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	75-77	6/12/2005	VXH
	125-126		
	78		
324	650		
	76.21		
	76.55		
	76.74		
361	78		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
702	75	6/12/2005	VXH
	125		
324	76.21		
324/76.55/76.74 361/78			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/12/2005	VXH
Inventor name search	6/12/2005	VXH